

Notice of References Cited	Application/Control No. 10/713,411	Applicant(s)/Patent Under Reexamination LEVENTHAL ET AL.	
	Examiner Ted T. Vo	Art Unit 2191	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Tamches, "Fine-Grained Dynamic Instrumentation of Commodity Operating System Kernels", University of Wisconsin, Pages: 1-141, 2001.
	V	Uhlig et al., "Trace-Driven Memory Simulation: A Survey", ACM, Pages 128-169, 6-1997.
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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